

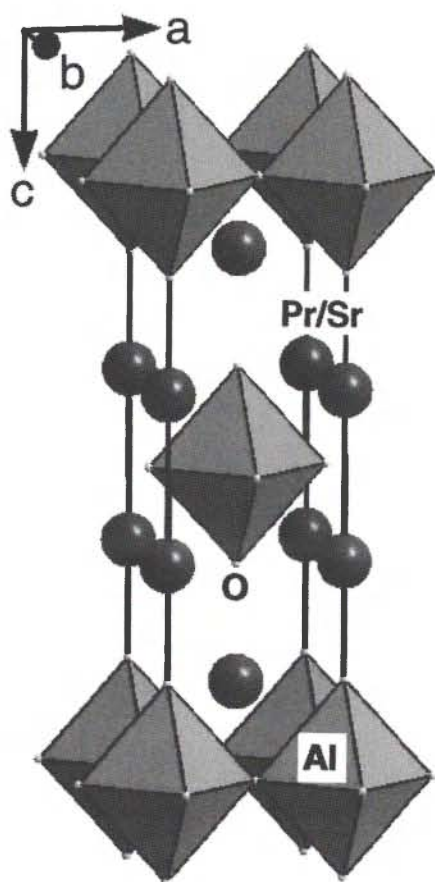
# Crystal structure of strontium praseodym aluminate, SrPrAlO<sub>4</sub>

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## Abstract

AlO<sub>4</sub>PrSr, tetragonal, *I4/mmm* (No. 139), *a* = 3.736(1) Å, *c* = 12.532(3) Å, *V* = 174.9 Å<sup>3</sup>, *Z* = 2, *R*<sub>gt</sub>(*F*) = 0.010, *wR*(*F*<sup>2</sup>) = 0.021, *T* = 293 K.

**Table 2.** Atomic coordinates and displacement parameters (in Å<sup>4</sup>).

Atom	Site	Occ.	<i>x</i>	<i>y</i>	<i>z</i>	<i>U</i> <sub>11</sub>	<i>U</i> <sub>22</sub>	<i>U</i> <sub>33</sub>	<i>U</i> <sub>12</sub>	<i>U</i> <sub>13</sub>	<i>U</i> <sub>23</sub>
Pr(1)	4 <i>e</i>	0.5	0	0	0.35845(5)	0.0043(2)	<i>U</i> <sub>11</sub>	0.0037(3)	0	0	0
Sr(1)	4 <i>e</i>	0.5	0	0	0.35845	0.0043	<i>U</i> <sub>11</sub>	0.0037	0	0	0
Al(1)	2 <i>a</i>		0	0	0	0.0041(7)	<i>U</i> <sub>11</sub>	0.007(2)	0	0	0
O(1)	4 <i>c</i>		0	1/2	0	0.004(2)	0.003(2)	0.008(3)	0	0	0
O(2)	4 <i>e</i>		0	0	0.1640(4)	0.011(1)	<i>U</i> <sub>11</sub>	0.008(4)	0	0	0

## Source of material

The single crystal of SrPrAlO<sub>4</sub> was grown by the Czochralski method in slightly reducing atmosphere with a growth rate of 1 mm/h. The starting materials were mixed in a non-stoichiometric ratio according to the formula SrPr<sub>1.066</sub>Al<sub>0.97</sub>O<sub>4</sub>. The resulting single crystal was of very good perfection and had green color.

## Discussion

SrPrAlO<sub>4</sub> crystal belongs to the ABCO<sub>4</sub> group of oxide crystals (A = Ca, Sr; B = rare earth elements and Al, Ga) with K<sub>2</sub>NiF<sub>4</sub>-structure which are very promising substrates for high-*T*<sub>c</sub> superconductors. These substrates are favoured for YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7-x</sub> epitaxy, mainly because of their isostructure with the superconductor and their good lattice matching and well suited dielectric properties.

**Table 1.** Data collection and handling.

Crystal:	green, irregular, size 0.1 × 0.1 × 0.1 mm
Wavelength:	Mo K <sub>α</sub> radiation (0.71073 Å)
μ:	291.10 cm <sup>-1</sup>
Diffractometer, scan mode:	Stoe IPDS, 140 exposures, Δφ = 1.7°
2θ <sub>max</sub> :	55.8°
<i>N</i> ( <i>hkl</i> ) <sub>measured</sub> , <i>N</i> ( <i>hkl</i> ) <sub>unique</sub> :	932, 85
Criterion for <i>I</i> <sub>obs</sub> , <i>N</i> ( <i>hkl</i> ) <sub>gt</sub> :	<i>I</i> <sub>obs</sub> > 2 σ( <i>I</i> <sub>obs</sub> ), 76
<i>N</i> ( <i>param</i> ) <sub>refined</sub> :	13
Program:	SHELXL-93 [2]

## References

1. Uecker, R.; Reiche, P.; Ganschow, S.: Conf. Proc. of the Eastern Regional Conference on Crystal Growth and Epitaxie, 28.9.-1.10.1997, Atlantic City, USA.
2. Sheldrick, G. M.: SHELXS-93. Program for the Refinement of Crystal Structures. University of Göttingen, Germany 1993.

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